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N-Channel 650V (D-S) Super Junction Power MOSFET

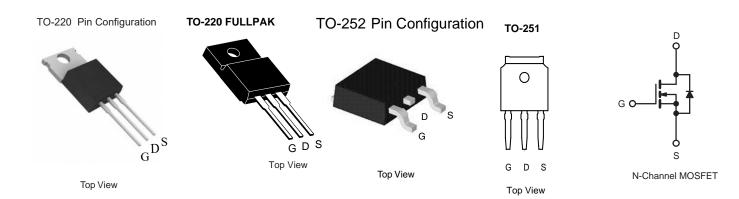
PRODUCT SUMMARY						
V _{DS} (V)	650					
R _{DS(on)} (Ω)	V _{GS} = 10 V	2.3				
Q _g (Max.) (nC)	31					
Q _{gs} (nC)	4.6					
Q _{gd} (nC)	17					
Configuration	Single					

FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- Dynamic dV/dt Rating
- · Low Thermal Resistance
- · Lead (Pb)-free Available



COMPLIANT



ABSOLUTE MAXIMUM RATINGS T	C = 23 C, u	liess outerw				
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	650	V	
Gate-Source Voltage			V _{GS}	± 20	7 V	
Continuous Drain Current	V _{GS} at 10 V	$T_{C} = 25 \text{ °C}$ $T_{C} = 100 \text{ °C}$	I _D	2.0		
	VGS AL TO V	$T_C = 100 ^{\circ}C$		1.6	А	
Pulsed Drain Current ^a			I _{DM}	10]	
Linear Derating Factor				0.28	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	250	mJ	
Repetitive Avalanche Current ^a			I _{AR}	1.5	A	
Repetitive Avalanche Energy ^a			E _{AR}	3.5	mJ	
Maximum Power Dissipation	$T_{\rm C} = 1$	25 °C	PD	35	W	
Peak Diode Recovery dV/dt ^c			dV/dt	3.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 1	0 s		300 ^d	50	
Mounting Torque	6.22 or M	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 OF WIS SCIEW			1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 73 mH, $R_G = 25 \Omega$, $I_{AS} = 1.5$ A (see fig. 12).

c. $I_{SD} \le 1.6$ A, dl/dt ≤ 60 A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply



DTP2N65SJ/DTP2N65FSJ/DTU2N65SJ/DTL2N65SJ www.din-tek.jp

THERMAL RESISTANCE RAT	FINGS							
PARAMETER	SYMBOL	TYP. MAX.			UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 65						
Maximum Junction-to-Case (Drain)	R _{thJC}	- 3.6				°C/W		
SPECIFICATIONS $T_J = 25 \degree C$,	unless otherv	vise noted						
PARAMETER	SYMBOL	1		ONS	MIN.	TYP.	MAX.	UNIT
Static					1		1	1
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = 250 \mu A$			650	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	Reference to 25 °C, I _D = 1 mA			0.62	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 2	250 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 20 \text{ V}$			-	-	± 100	nA
	I _{DSS}	V _{DS} = 650 V, V _{GS} = 0 V			-	-	100	<u> </u>
Zero Gate Voltage Drain Current		V _{DS} = 480 V	′, V _{GS} = 0 V	, T _J = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D	= 1.5 A ^b	-	2.3	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D =	1.5 A ^b	2.2	-	-	S
Dynamic		•						
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$ f = 1.0 MHz, see fig. 5 f = 1.0 MHz		-	660	-	pF	
Output Capacitance	C _{oss}			-	86	-		
Reverse Transfer Capacitance	C _{rss}			-	19	-		
Drain to Sink Capacitance	С			-	12	-		
Total Gate Charge	Qg			-	-	31		
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		A, V _{DS} = 360 V, g. 6 and 13 ^b	-	-	4.6	nC
Gate-Drain Charge	Q _{gd}	see ng		g. o and to	-	-	17	1
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 300 \text{ V}, \text{ I}_{D} = 1.6 \text{ A}, \\ \text{R}_{\text{G}} = 12 \Omega, \text{ R}_{D} = 82 \Omega, \\ \text{see fig. } 10^{\text{b}}$		-	11	-	- ns	
Rise Time	t _r			-	13	-		
Turn-Off Delay Time	t _{d(off)}			-	35	-		
Fall Time	t _f			-	14	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH	
Internal Source Inductance	Ls			-	7.5	-		
Drain-Source Body Diode Characteristic	S				1	1	1	
Continuous Source-Drain Diode Current	١ _S	MOSFET symbol showing the		-	-	2.0	A	
Pulsed Diode Forward Current ^a	I _{SM}	p - n junction diode			-	-		10
Body Diode Voltage	V_{SD}	T_J = 25 °C, I_S = 1.5 A, V_{GS} = 0 V ^b			-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}			-	400	810	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 \text{ °C}, I_F = 1.6 \text{ A}, \text{ dl/dt} = 100 \text{ A/}\mu\text{s}^b$			-	2.1	4.2	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time i	s negligible (turn	-on is dor	ninated by	, L _S and I	_D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



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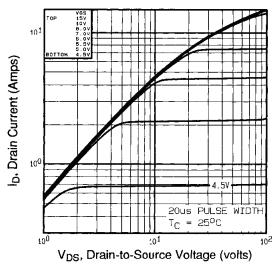
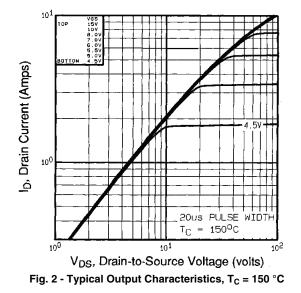
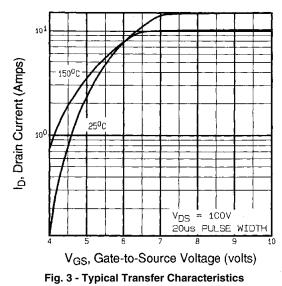


Fig. 1 - Typical Output Characteristics, T_C = 25 °C





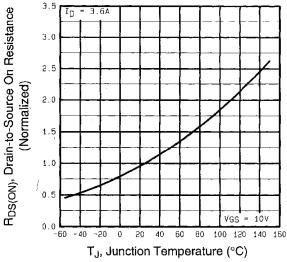
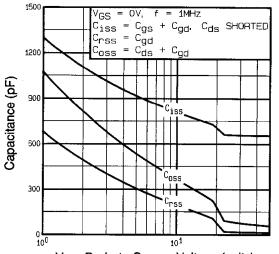


Fig. 4 - Normalized On-Resistance vs. Temperature



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V_{DS}, Drain-to-Source Voltage (volts) Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

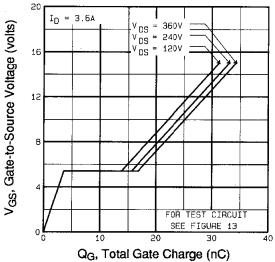
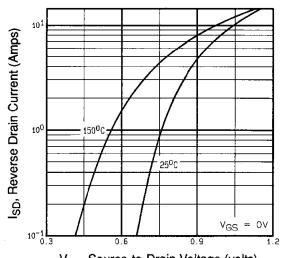
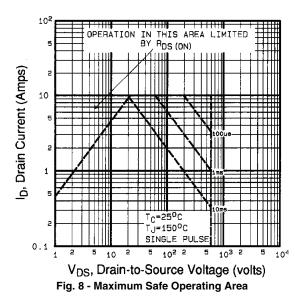


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



V_{SD}, Source-to-Drain Voltage (volts) Fig. 7 - Typical Source-Drain Diode Forward Voltage





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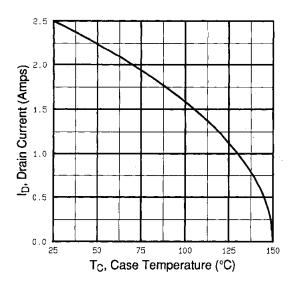


Fig. 9 - Maximum Drain Current vs. Case Temperature

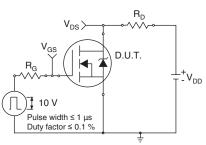


Fig. 10a - Switching Time Test Circuit

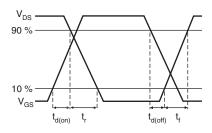
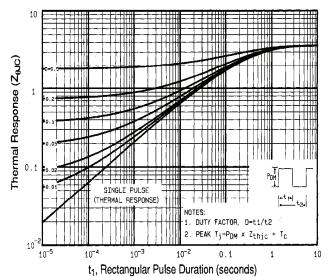


Fig. 10b - Switching Time Waveforms





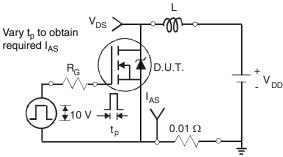


Fig. 12a - Unclamped Inductive Test Circuit

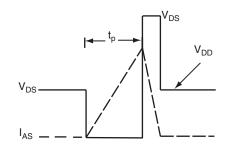


Fig. 12b - Unclamped Inductive Waveforms



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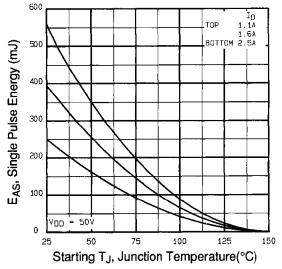


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

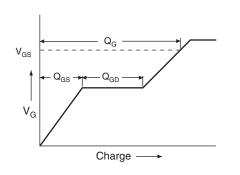


Fig. 13a - Basic Gate Charge Waveform

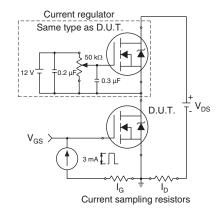
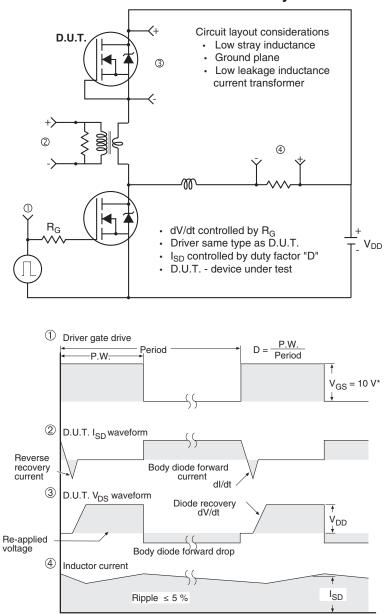


Fig. 13b - Gate Charge Test Circuit



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Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel



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